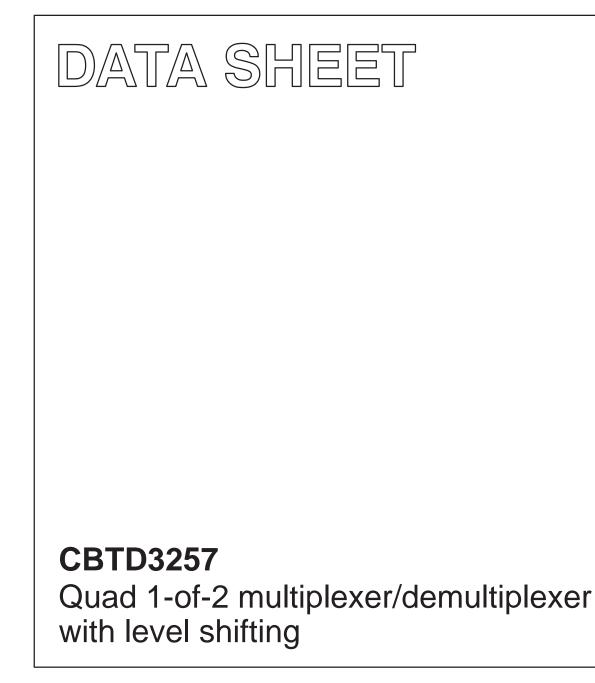
INTEGRATED CIRCUITS



Preliminary data

2002 Sep 09





CBTD3257

FEATURES

- 5 Ω switch connection between two ports
- TTL-compatible input levels
- Designed to be used in level shifting applications
- Minimal propagation delay through the switch
- Latch-up protection exceeds 500 mA per JESD78
- ESD protection exceeds 2000 V HBM per JESD22-A114, 200 V MM per JESD22-A115 and 1000 V CDM per JESD22-C101

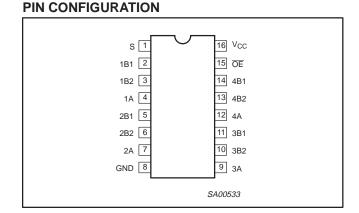
DESCRIPTION

The CBTD3257 is a quad 1-of-2 high-speed TTL-compatible multiplexer/demultiplexer. The low on resistance of the switch allows inputs to be connected to outputs without adding propagation delay or generating additional ground bounce noise.

Output Enable (\overline{OE}) and select-control (S) inputs select the appropriate B1 and B2 outputs for the A-input data.

Internal diode allows voltage level shifting from 5 V inputs to 3.3 V outputs.

The CBTD3257 is characterized for operation from -40 to +85 °C.



PIN DESCRIPTION

PIN NUMBER	SYMBOL	NAME AND FUNCTION
1	S	Select-control input
2, 3, 5, 6, 10, 11, 13, 14	1B1, 1B2, 2B1, 2B2 3B1, 3B2 4B1, 4B2	B outputs
4, 7, 9, 12	1A, 2A, 3A, 4A	A inputs
8	GND	Ground (0 V)
15	ŌĒ	Output enable
16	V _{CC}	Positive supply voltage

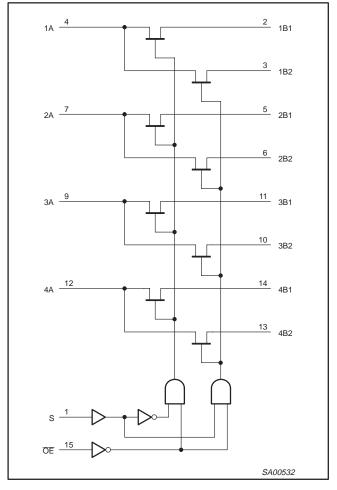
ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	ORDER CODE	TOPSIDE MARK	DWG NUMBER
16-pin plastic SO	–40 to 85 °C	CBTD3257D	CBTD3257D	SOT109-1
16-pin plastic SSOP	–40 to 85 °C	CBTD3257DB	CD3257	SOT338-1
16-pin plastic SSOP (QSOP)	–40 to 85 °C	CBTD3257DS	CBD3257	SOT519-1
16-pin plastic TSSOP	–40 to 85 °C	CBTD3257PW	CBD3257	SOT403-1

Standard packing quantities and other packaging data is available at www.philipslogic.com/packaging.

CBTD3257

LOGIC DIAGRAM (positive logic)



FUNCTION TABLE

INP	UTS	FUNCTION
OE	S	FUNCTION
L	L	A port = B1 port
L	Н	A port = B2 port
н	Х	Disconnect

CBTD3257

ABSOLUTE MAXIMUM RATINGS¹

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		-0.5 to +7.0	V
VI	DC input voltage ²		-0.5 to +7.0	V
	Continuous channel current		128	mA
۱ _K	Input clamp current	V _{I/O} < 0	-50	mA
T _{stg}	Storage temperature range		-65 to +150	°C

NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

2. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIM	UNIT	
	PARAMETER	MIN	MAX	UNIT
V _{CC}	DC supply voltage	4.5	5.5	V
V _{IH}	High-level input voltage	2.0	—	V
V _{IL}	Low-level Input voltage	—	0.8	V
T _{amb}	Operating free-air temperature range	-40	+85	°C

NOTE:

1. All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation.

DC ELECTRICAL CHARACTERISTICS

	OL PARAMETER			LIMITS			UNIT
SYMBOL			TEST CONDITIONS	T _{amb} = −40 to +85 °C			
				MIN	TYP ¹	MAX	
V _{IK}	Input clamp voltage		$V_{CC} = 4.5 \text{ V}; \text{ I}_{\text{I}} = -18 \text{ mA}$	—	—	-1.2	V
VP	Pass voltage		$V_{I} = V_{CC} = 5.5 \text{ V}; \text{ I/O} = -100 \text{ mA}$	See Figure 1			
lı	Input leakage current		$V_{CC} = 5.5 \text{ V}; \text{ V}_{I} = \text{GND or } 5.5 \text{ V}$	—	—	±1	μΑ
I _{CC}	Quiescent supply current		$V_{CC} = 5.5 \text{ V}; I_O = 0, V_I = V_{CC} \text{ or GND}$	—	—	1.5	mA
ΔI_{CC}	Additional supply current per input pin ²		V_{CC} = 5.5 V, one input at 3.4 V, other inputs at V_{CC} or GND	—	_	2.5	mA
Cl	Control pins		V _I = 3 V or 0	—	4.5	—	pF
<u>_</u>	Dower off lookage ourrest	A port	$V_{O} = 3 V \text{ or } 0; \overline{OE} = V_{CC}$	—	12.5	—	pF
C _{IO(OFF)}	Power-off leakage current B port		$V_{O} = 3 V \text{ or } 0; \overline{OE} = V_{CC}$	—	6.5	—	pF
	r _{on} ³ On-resistance		$V_{CC} = 4.5 \text{ V}; \text{ V}_{I} = 0 \text{ V}; \text{ I}_{I} = 64 \text{ mA}$	—	5	7	Ω
r _{on} ³			$V_{CC} = 4.5 \text{ V}; \text{ V}_{I} = 0 \text{ V}; \text{ I}_{I} = 30 \text{ mA}$	—	5	7	Ω
			$V_{CC} = 4.5$ V; V _I = 2.4 V; I _I = 15 mA	_	16	50	Ω

NOTES:

All typical values are at V_{CC} = 5 V, T_{amb} = 25 °C.
This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND

Measured by the voltage drop between the A and the B terminals at the indicated current through the switch. On-state resistance is determined by the lowest voltage of the two (A or B) terminals.

CBTD3257

AC CHARACTERISTICS

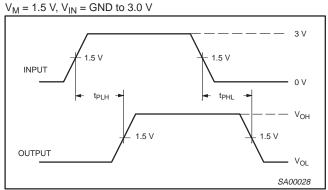
 $T_{amb} = -40$ to +85 °C; $C_L = 50$ pF

			LIMITS		ITS		
SYMBOL	PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = +5.0 V ±0.5 V		UNIT	
			(00000)	MIN	MAX		
t _{pd}	Propagation delay ¹	A or B	B or A	_	0.25	ns	
t _{pd}	Propagation delay	S	A	1.6	11.0	ns	
	Output enable time	ŌĒ	A or B	1.8	11.2	ns	
t _{en}	to High and Low level	S	В	1.6	10.8	ns	
	Output disable time	OE	A or B	2.2	6.0	ns	
t _{dis}	from High and Low level	S	В	2.0	8.0	ns	

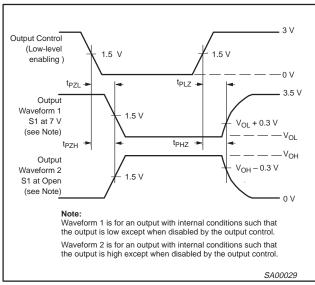
NOTE:

1. The propagation delay is the calculated RC time constant of the typical on-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).

AC WAVEFORMS



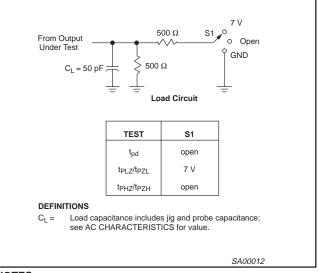




Waveform 2. 3-State Output Enable and Disable Times NOTES:

- 1. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- 2. t_{PZL} and t_{PZH} are the same as t_{en}.
- 3. t_{PLH} and t_{PHL} are the same as t_{pd}.

TEST CIRCUIT AND WAVEFORMS



NOTES:

- 1. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 $\Omega,\,t_r$ \leq 2.5 ns. t_f \leq 2.5 ns.
- 2. The outputs are measured one at a time with one transition per measurement.

CBTD3257

TYPICAL CHARACTERISTICS

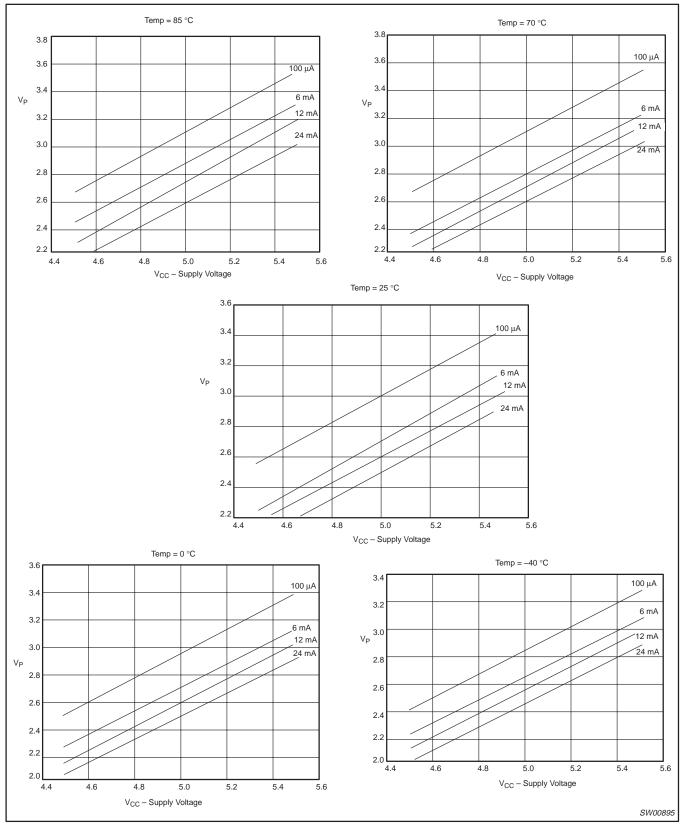
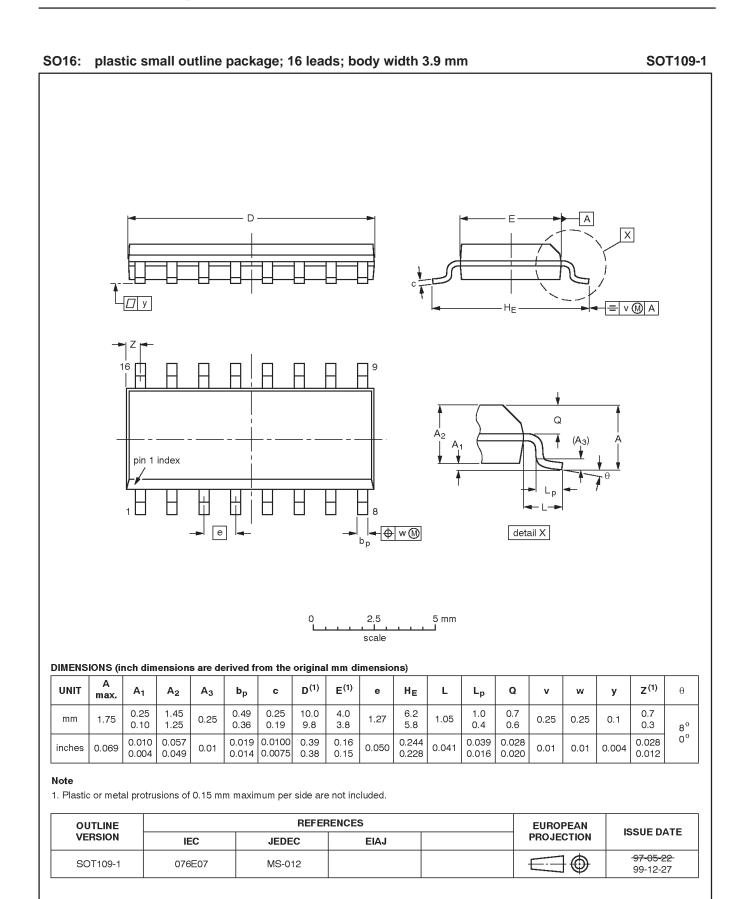


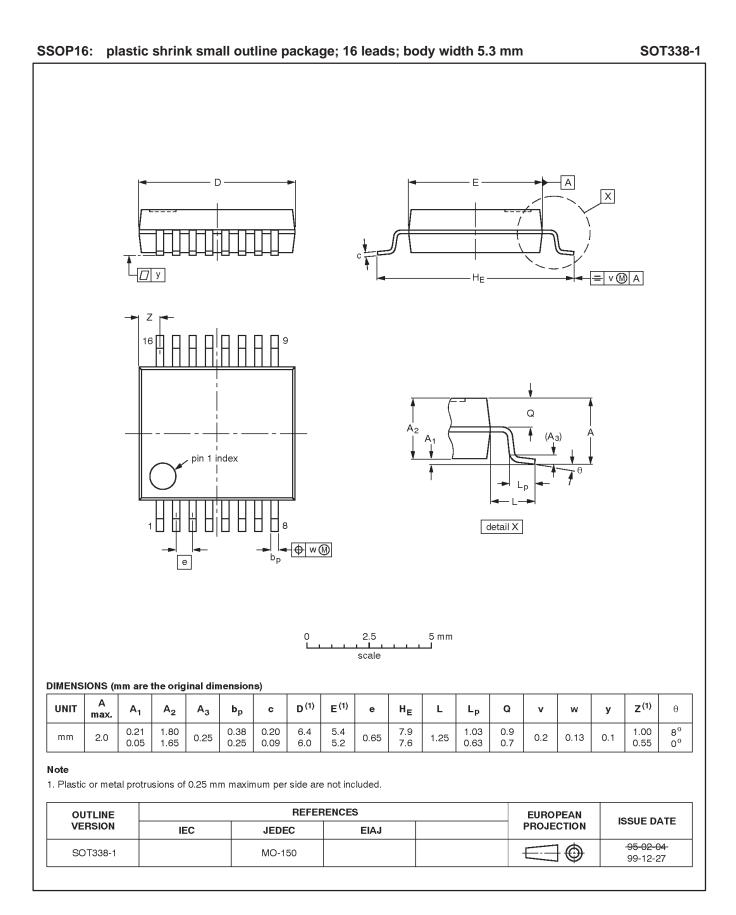
Figure 1. V_{OH} values ($V_{in} = V_{CC}$)

Preliminary data

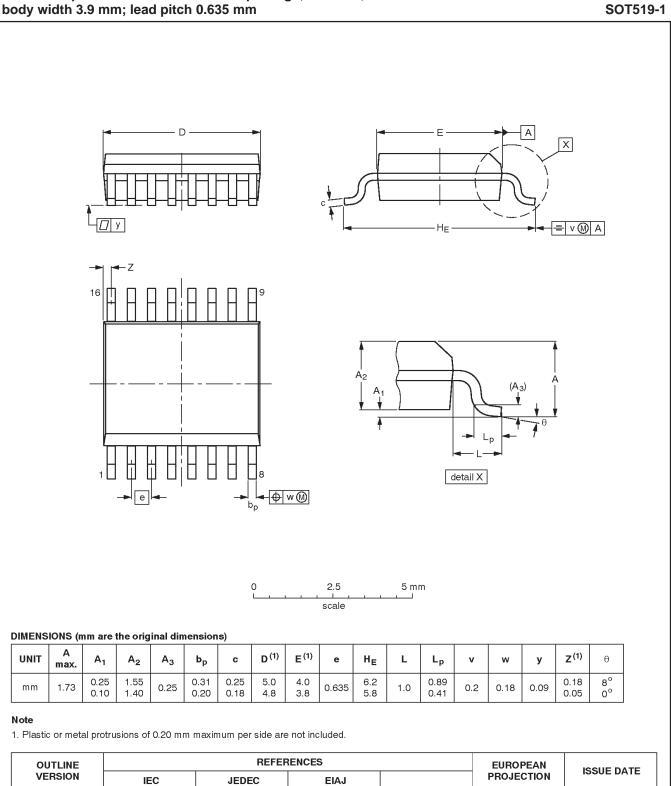


Preliminary data

CBTD3257



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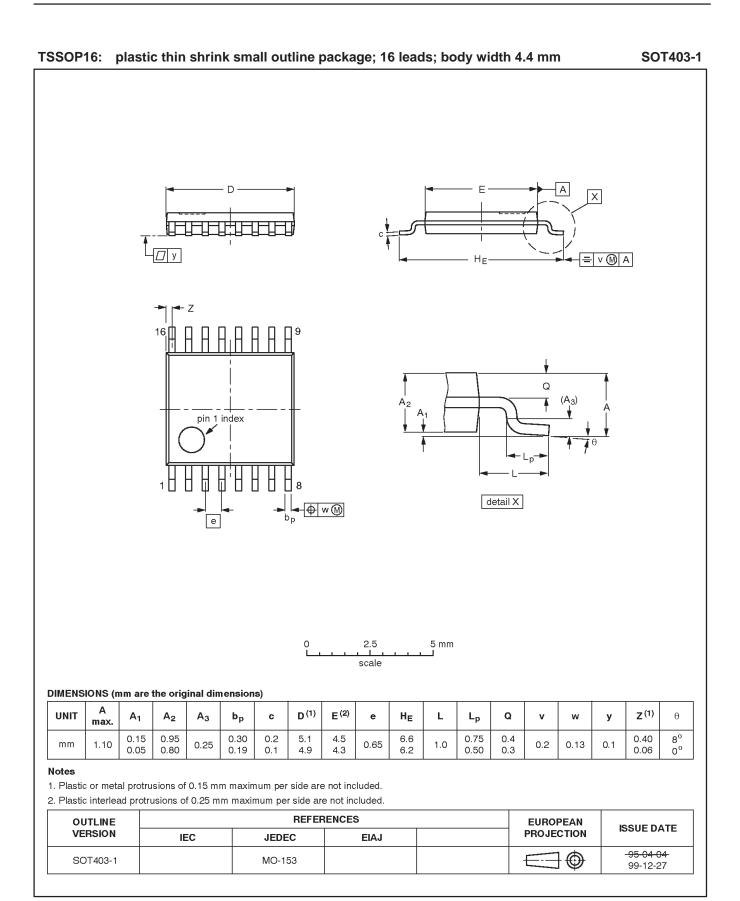
SSOP16: plastic shrink small outline package; 16 leads;

SOT519-1

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99-05-04

CBTD3257



Data sheet status

Data sheet status ^[1]	Product status ^[2]	Definitions
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
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[1] Please consult the most recently issued data sheet before initiating or completing a design.

[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.

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